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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Naoki TADA et al.

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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP03/02412. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

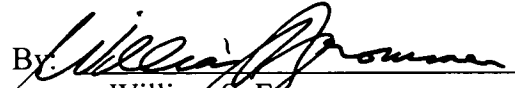
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Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

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Based on Form PTO-1449 (3/90) LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. 450100-04423	SERIAL NO. Filed Concurrently Herewith
	APPLICANT Naoki TADA et al.	
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
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/M.E./	AL	WO 01/27733	04/19/01	PCT			
/M.E./	AM	JP 2001-184158	07/06/01	Japan			
/M.E./	AN	JP 8-161103	06/21/96	Japan			
/M.E./	AO	JP 2001-92582	04/06/01	Japan			
/M.E./	AP	JP 8-18632	01/19/96	Japan			
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